



A LIMITED LIABILITY COMPANY

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KLA 2139 SMIF WAFER INSPECTION SYSTEM

Serial Number: W21XX1337

Mfg. Date: October 2000

SECS II/GEM Communication Interface
Pentium III dual processor CPU with Windows NT
Installed
NT box option-direct link/direct SECS
FeB dissociation light assembly
Mercury Xenon Lamp
Light level sensor with adjustable 2x Mag Tubes
X/Y/Z drive/controller chassis and motion controller card
High voltage electronics
Granite stage
Autofocus III with 200mm Collimating Lens
Standard Chuck
15 inch Sony Monitor
15 inch Image Computer monitor
User Interface Monitor
Left or Right hand side User interface
Remote Power Distribution Panel
Wafer handling module
Cassette ergo loaders
Auto Defect Calibration enable option
Direct Link hardware with ADC review optics
EMO s with switch covers

Specifications

- 1) UBB, Ultra Brightfield illumination
- 2) High Numerical aperture (NA) optics
- 3) Spotsize: 0.16um,0.25um,0.39um,0.625um & 5um
- 4) SAT (Segmented Auto Threshold)



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